

Search Notes**Application/Control No.**

10/033,430

Examiner

Hanh Phan

Applicant(s)/Patent under Reexamination

WON, KING L.

Art Unit

2638

SEARCHED

Class	Subclass	Date	Examiner
398	25	08/30/05	MP
	26		
	27		
	33		
	34		
	35		
	38		
	79		
	177		
	140		
	141		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Ext search see attached print out in the file.	08/30/05	MP
Intl search.		
JPO search.		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner